

Notice of References Cited	Application/Control No. 10/765,929		Applicant(s)/Patent Under Reexamination AONO ET AL.	
	Examiner Laura E. Martin		Art Unit 2853	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,521,031	02-2003	Kimura et al.	106/31.47
*	B	US-2002/0067399	06-2002	Yabuki et al.	347/100
*	C	US-6,509,125	01-2003	Ito et al.	430/7
*	D	US-6,048,660	04-2000	Leppard et al.	430/270.1
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001181548 A	07-2001	Japan	ISHIZUKA et al.	C09D 17/00
	O	JP 10095942 A	04-1998	Japan	KUBODERA, SEIICHI	C09D 11/02
	P	JP 2002088294 A	03-2002	Japan	ISHIZUKA et al.	C09D 17/00
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.